

**Search Notes**

Application/Control No.

10/630,833

Examiner

Thien F. Tran

Applicant(s)/Patent under  
Reexamination

EGUCHI ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	340, 394	1/13/2005	TT
257	409, 488	1/13/2005	TT
257	630	1/13/2005	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
257	340, 394	1/13/2005	TT
257	409, 488	1/13/2005	TT
257	630	1/13/2005	TT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR